

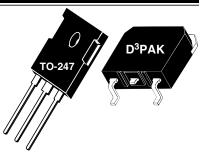
# APT5014BLL(G) APT5014SLL(G)

**500V 35A 0.140**Ω

\*G Denotes RoHS Compliant, Pb Free Terminal Finish.

# POWER MOS 7<sup>®</sup> MOSFET

Power MOS  $7^{\circ}$  is a new generation of low loss, high voltage, N-Channel enhancement mode power MOSFETS. Both conduction and switching losses are addressed with Power MOS  $7^{\circ}$  by significantly lowering  $R_{DS(ON)}$  and  $Q_{g}$ . Power MOS  $7^{\circ}$  combines lower conduction and switching losses along with exceptionally fast switching speeds inherent with APT's patented metal gate structure.



• Lower Input Capacitance

Increased Power Dissipation

• Lower Miller Capacitance

Easier To Drive

Lower Gate Charge, Qg

• TO-247 or Surface Mount D3PAK Package



#### **MAXIMUM RATINGS**

All Ratings:  $T_C = 25^{\circ}C$  unless otherwise specified.

Symbol	Parameter	APT5014BLL-SLL(G)	UNIT	
V <sub>DSS</sub>	Drain-Source Voltage	500	Volts	
I <sub>D</sub>	Continuous Drain Current @ T <sub>C</sub> = 25°C	35	Amps	
I <sub>DM</sub>	Pulsed Drain Current <sup>①</sup>	140		
V <sub>GS</sub>	Gate-Source Voltage Continuous	±30	Volts	
V <sub>GSM</sub>	Gate-Source Voltage Transient	±40	Volto	
$P_{D}$	Total Power Dissipation @ T <sub>C</sub> = 25°C	403	Watts	
' D	Linear Derating Factor	3.22	W/°C	
$T_J$ , $T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	٥̈	
$T_L$	Lead Temperature: 0.063" from Case for 10 Sec.	300		
I <sub>AR</sub>	Avalanche Current (1) (Repetitive and Non-Repetitive)	35	Amps	
E <sub>AR</sub>	Repetitive Avalanche Energy (1)	30	mJ	
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>4</sup>	1300	mJ	

#### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage $(V_{GS} = 0V, I_D = 250\mu\text{A})$	500			Volts
R <sub>DS(on)</sub>	Drain-Source On-State Resistance ② (V <sub>GS</sub> = 10V, 17.5A)			0.140	Ohms
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V)			100	μA
	Zero Gate Voltage Drain Current (V <sub>DS</sub> = 400V, V <sub>GS</sub> = 0V, T <sub>C</sub> = 125°C)			500	
I <sub>GSS</sub>	Gate-Source Leakage Current (V <sub>GS</sub> = ±30V, V <sub>DS</sub> = 0V)			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage $(V_{DS} = V_{GS}, I_{D} = 1 \text{mA})$	3		5	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

### **DYNAMIC CHARACTERISTICS**

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V		3261		
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V		704		рF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		50		
$Q_g$	Total Gate Charge <sup>③</sup>	V <sub>GS</sub> = 10V		72		
$Q_gs$	Gate-Source Charge	V <sub>DD</sub> = 250V		20		nC
$Q_{gd}$	Gate-Drain ("Miller") Charge	I <sub>D</sub> = 35A @ 25°C		36		
t <sub>d(on)</sub>	Turn-on Delay Time	RESISTIVE SWITCHING  V <sub>GS</sub> = 15V		11		
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 250V		6		
t <sub>d(off)</sub>	Turn-off Delay Time	I <sub>D</sub> = 35A @ 25°C		23		ns
t <sub>f</sub>	Fall Time	$R_{G} = 1.6\Omega$		3		
E <sub>on</sub>	Turn-on Switching Energy <sup>⑥</sup>	INDUCTIVE SWITCHING @ 25°C  V <sub>DD</sub> = 333V, V <sub>GS</sub> = 15V		325		
E <sub>off</sub>	Turn-off Switching Energy	$I_D = 35A, R_G = 5\Omega$		249		
E <sub>on</sub>	Turn-on Switching Energy <sup>⑥</sup>	INDUCTIVE SWITCHING @ 125°C  V <sub>DD</sub> = 333V, V <sub>GS</sub> = 15V		545		μJ
E <sub>off</sub>	Turn-off Switching Energy	$I_D = 35A, R_G = 5\Omega$		288	_	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
I <sub>s</sub>	Continuous Source Current (Body Diode)			35	Amps
I <sub>SM</sub>	Pulsed Source Current ① (Body Diode)			140	Allips
V <sub>SD</sub>	Diode Forward Voltage ② (V <sub>GS</sub> = 0V, I <sub>S</sub> = -35A)			1.3	Volts
t <sub>rr</sub>	Reverse Recovery Time $(I_S = -35A, dI_S/dt = 100A/\mu s)$		510		ns
Q <sub>rr</sub>	Reverse Recovery Charge $(I_S = -35A, dI_S/dt = 100A/\mu s)$		10		μC
dv/ <sub>dt</sub>	Peak Diode Recovery dv/ <sub>dt</sub> (5)			8	V/ns

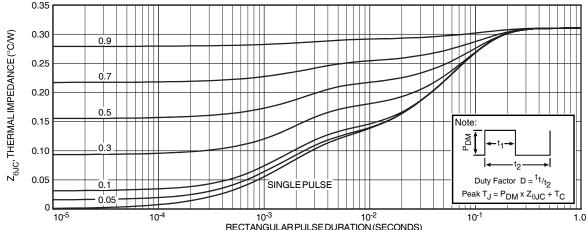
### **THERMAL CHARACTERISTICS**

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.31	°C/W
$R_{\theta JA}$	Junction to Ambient			40	C/VV

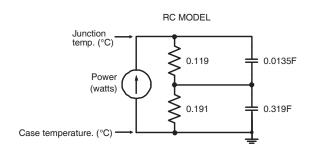
- ① Repetitive Rating: Pulse width limited by maximum junction temperature
- ② Pulse Test: Pulse width < 380  $\mu$ s, Duty Cycle < 2%
- ③ See MIL-STD-750 Method 3471

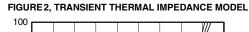
- 4 Starting T<sub>j</sub> = +25°C, L = 2.12mH, R<sub>G</sub> = 25 $\Omega$ , Peak I<sub>L</sub> = 35A
- 6 Eon includes diode reverse recovery. See figures 18, 20.

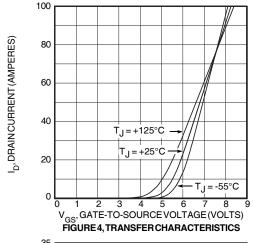
APT Reserves the right to change, without notice, the specifications and information contained herein.

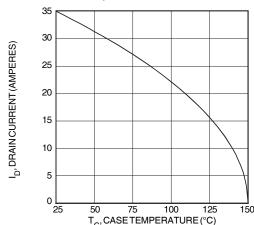


RECTANGULAR PULSE DURATION (SECONDS)
FIGURE 1, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

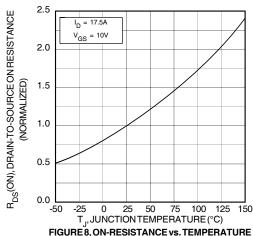


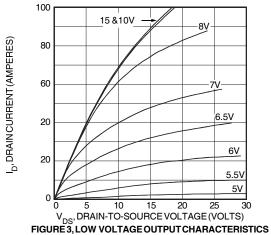


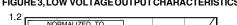


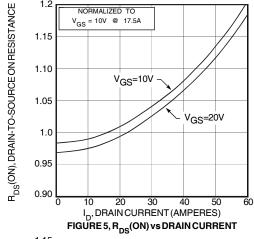


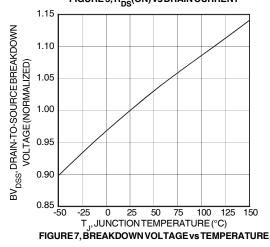
## T<sub>C</sub>, CASE TEMPERATURE (°C) FIGURE 6, MAXIMUM DRAIN CURRENT vs CASE TEMPERATURE

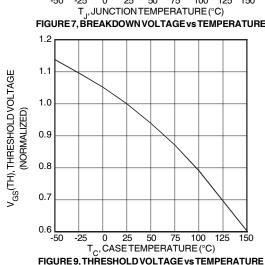




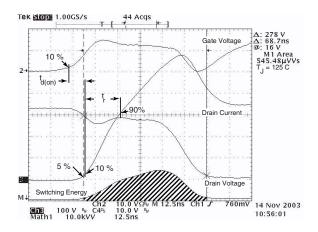








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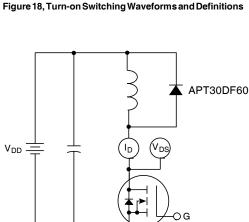


Figure 20, Inductive Switching Test Circuit

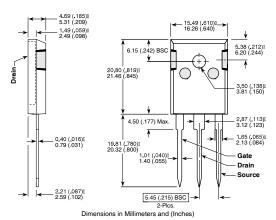
D.U.T.

# Tek Stop: 1.00GS/s 90% Drain Voltage 90% Drain Current 14 Nov 2003 Ch3 100 V % C45 Math1 10.0kVV

Figure 19, Turn-off Switching Waveforms and Definitions

### **TO-247 Package Outline**

e1 SAC: Tin, Silver, Copper



## D<sup>3</sup>PAK Package Outline

e3 100% Sn Plated

